### **RD50-MPW2 timing measurements** with Sr-90

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# RD50-MPW2

LFoundry 150 nm, 1900  $\Omega$ cm, V<sub>bias</sub>= -100 V

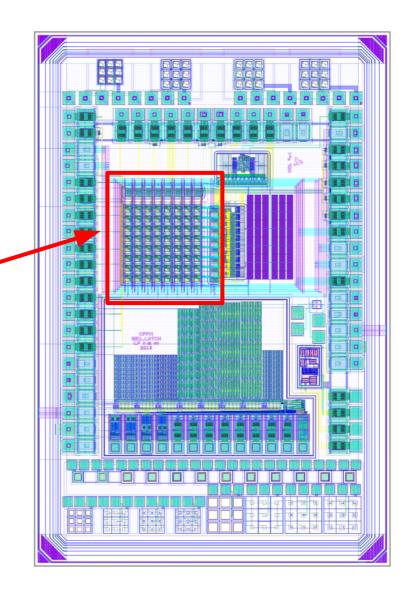
CMOS chip, designed by Liverpool and Vienna

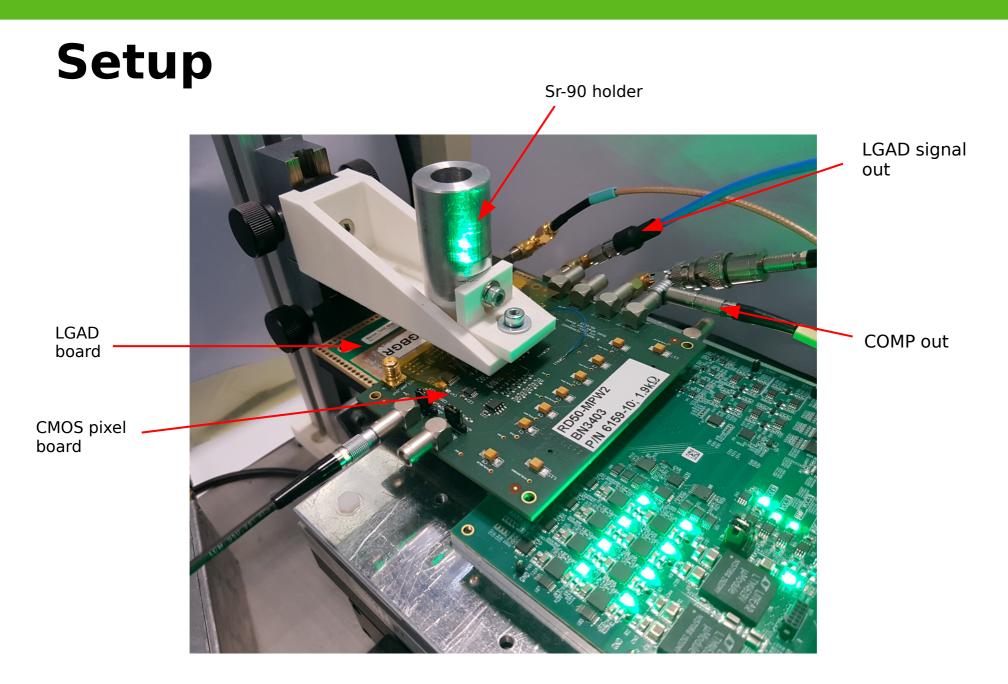
8x8 active pixel matrix (60x60 μm<sup>2</sup> pixel size) Large electrode pixel

Continuous-reset pixel

Time over threshold proportional to injected charge

Timing and jitter measurements with Sr-90





MPW2 board mounted on stages for alignment

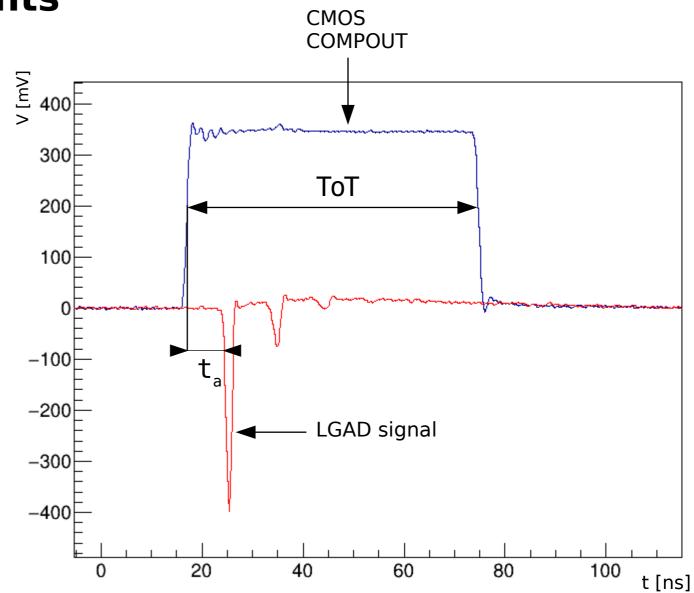
# Measurements

Reading out single 60x60 µm<sup>2</sup> pixel, Rate ~100 events/h

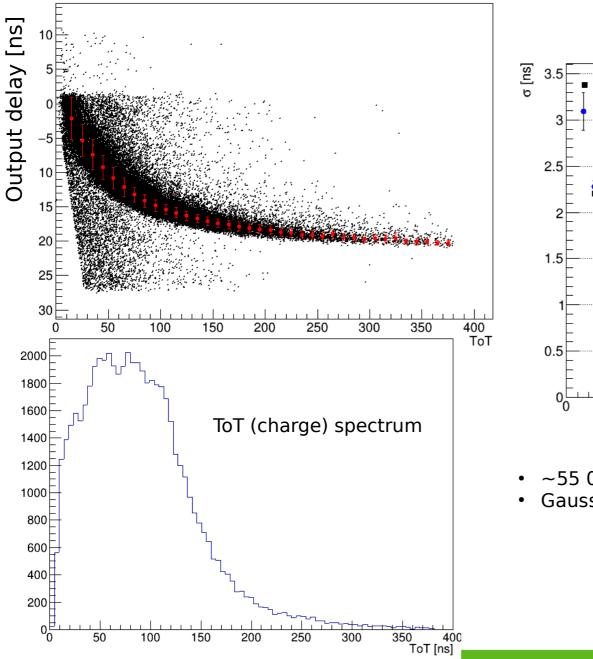
Thresholds: CMOS - 200 mV LGAD - CFD at 20%

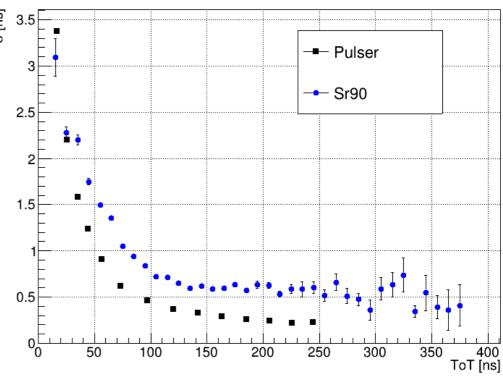
Trigger:

Both channels simultaneously over their respective thresholds → Coincidence event



#### Unirradiated sample

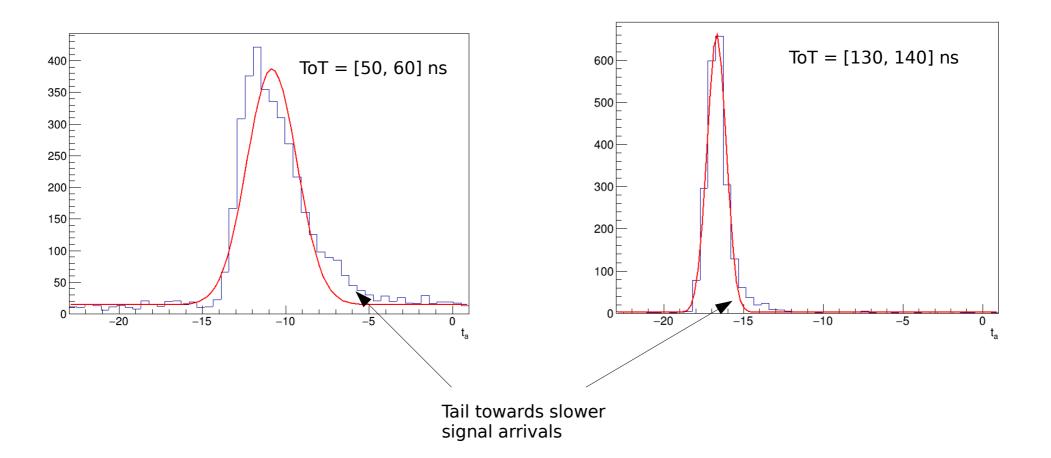




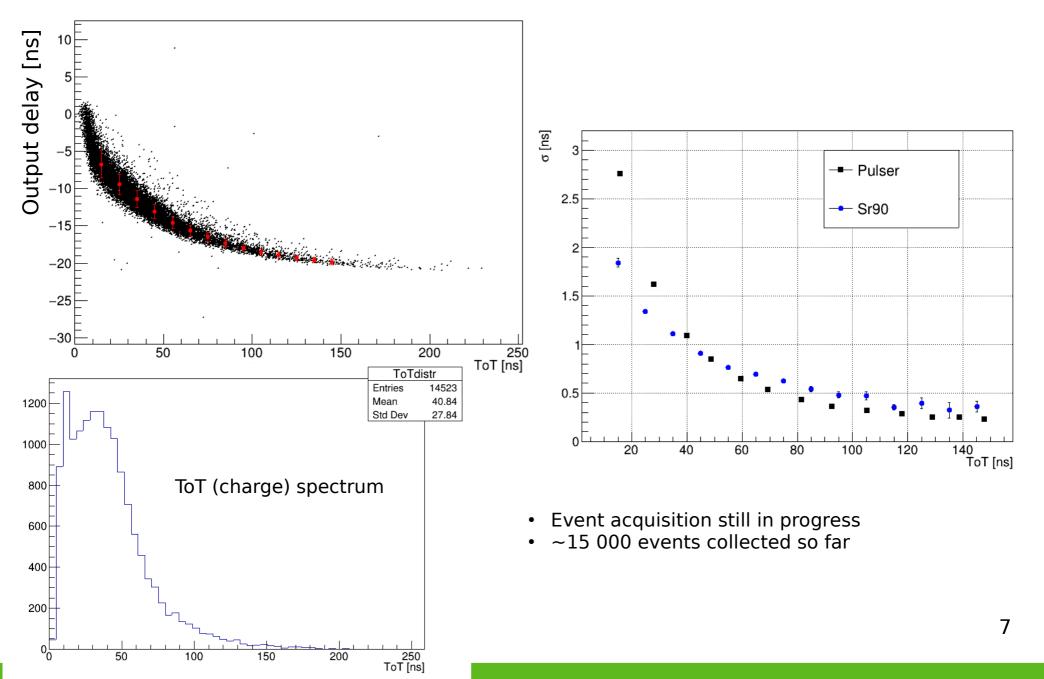
~55 000 events recorded

Gaussian fit with background

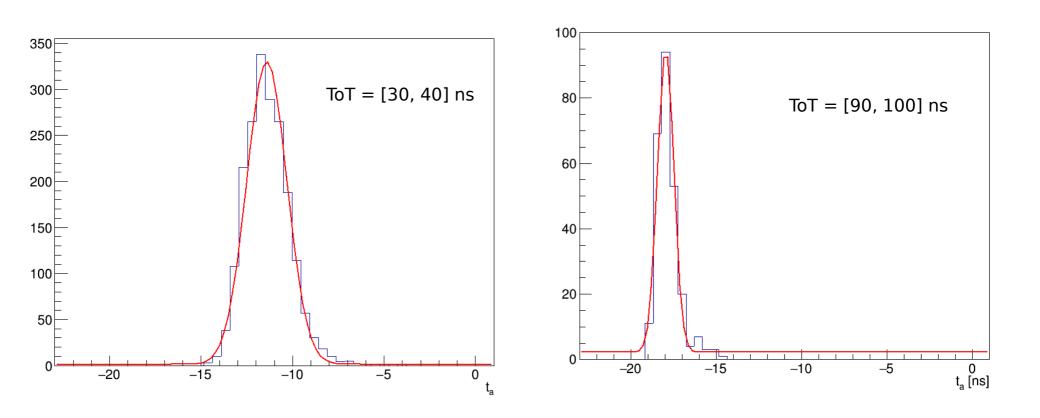
#### Unirradiated sample



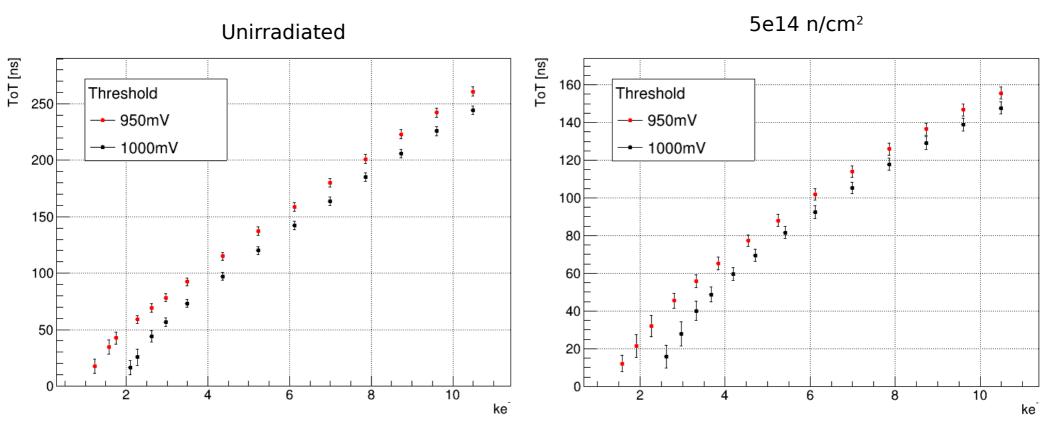
5e14 n/cm<sup>2</sup> sample

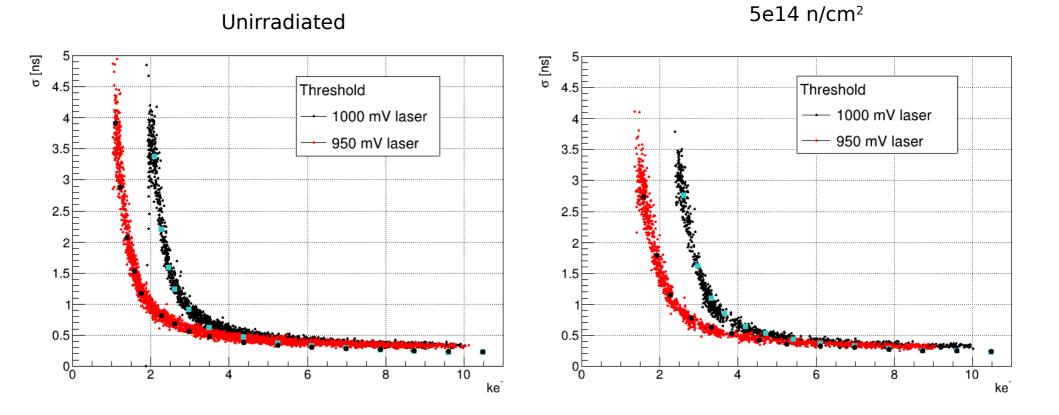


5e14 n/cm<sup>2</sup> sample



- Tails in distributions not present in irradiated sample
- More charge reaching the depletion layer via diffusion in unirradiated sample due to slower recombination





11

